

**External visual test method**

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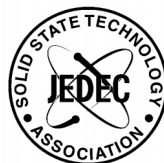
IEC/PAS 62163:2000

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**PUBLICLY AVAILABLE SPECIFICATION**



INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION



Reference number  
**IEC/PAS 62163**

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

## EXTERNAL VISUAL TEST METHOD

## FOREWORD

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IEC-PAS 62163 was submitted by JEDEC and has been processed by IEC technical committee 47: Semiconductor devices.

The text of this PAS is based on the following document:

This PAS was approved for publication by the P-members of the committee concerned as indicated in the following document:

Draft PAS	Report on voting
47/1463/PAS	47/1496/RVD

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